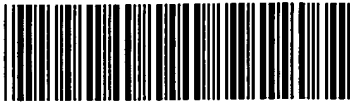


Search Notes

Application/Control No.

10/646,705

Examiner

Mathieu D. Vargot

Applicant(s)/Patent under
Reexamination

ICHIKAWA ET AL.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
264	1-1, 1.7		
623	5-11,		
	6-11		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR